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TAK CHEONG ELECTRONICS SHANWEI CO., LTD. BUBIAN INDUSTRIAL ZONE, SHANWEI CITY, GUANGDONG, P.R.C.



### The following sample(s) was/were submitted and identified by/on behalf of the client as :

Sample Description

SOD PRODUCT

SGS Ref No.

SZ11636917-2.1

Style/Item No.

SOD123, SOD323, SOD523

Sample Receiving Date

2009/02/27

**Testing Period** 

2009/02/27 TO 2009/03/05

**Test Requested** 

In accordance with the RoHS Directive 2002/95/EC, and its amendment directives.

**Test Method** 

With reference to IEC 62321: 2008

Procedures for the Determination of Levels of Regulated Substances in

Electrotechnical Products.

Determination of Cadmium by ICP-AES.

Determination of Lead by ICP-AES.

(3) Determination of Mercury by ICP-AES.

Determination of Hexavalent Chromium by Spot test / boiling water extraction

Method.

Test Result(s)

Please refer to next page(s).

Nicole Chien / Supervisor Signed for and on behalf of SGS TAIWAN LTD. **Chemical Laboratory - Taipei** 

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Test results by chemical method (Unit: mg/kg)

Test Item (s):	Method (Refer to)	Result No.1	MDL
Lead (Pb)	(2)	22	2
Mercury (Hg)	(3)	n.d.	2
Hexavalent Chromium Cr(VI) by Spot test / boiling water extraction	(4)	Negative	See Note 4

#### **TEST PART DESCRIPTION:**

NO.1

MIXED SILVER COLORED METAL (INCLUDING THE PLATING LAYER) (3 TYPE)

- Note: 1. mg/kg = ppm; 0.1wt% = 1000ppm
  - 2. n.d. = Not Detected
  - 3. MDL = Method Detection Limit
  - 4. Spot-test:

Negative = Absence of Cr(VI) coating / surface layer,

Positive = Presence of Cr(VI) coating / surface layer;

(The tested sample should be further verified by boiling-water-extraction method if the spot test result cannot be confirmed.)

#### Boiling-water-extraction:

Negative = Absence of Cr(VI) coating / surface layer.

Positive = Presence of Cr(VI) coating / surface layer;

the detected concentration in boiling-water-extraction solution is equal or greater

than 0.02 mg/kg with 50 cm<sup>2</sup> sample surface area.

5. The sample(s) was/were analyzed on behalf of the applicant as mixing sample in one testing. The above result(s) was/were only given as the informality value.

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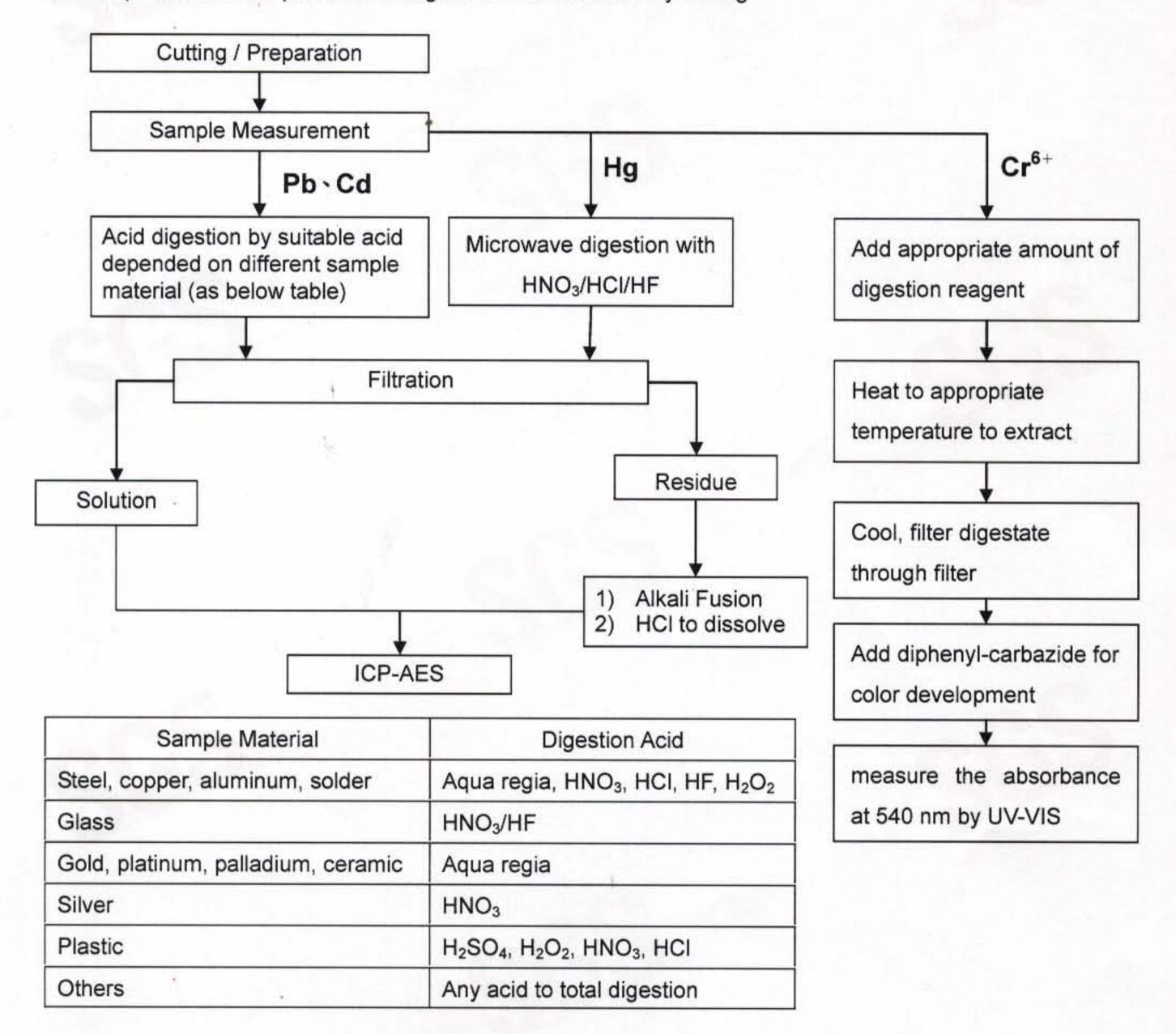


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- These samples were dissolved totally by pre-conditioning method according to below flow chart.
   (Qr<sup>6+</sup> test method excluded)
- 2) Name of the person who made measurement: Climbgreat Yang
- 3) Name of the person in charge of measurement: Troy Chang



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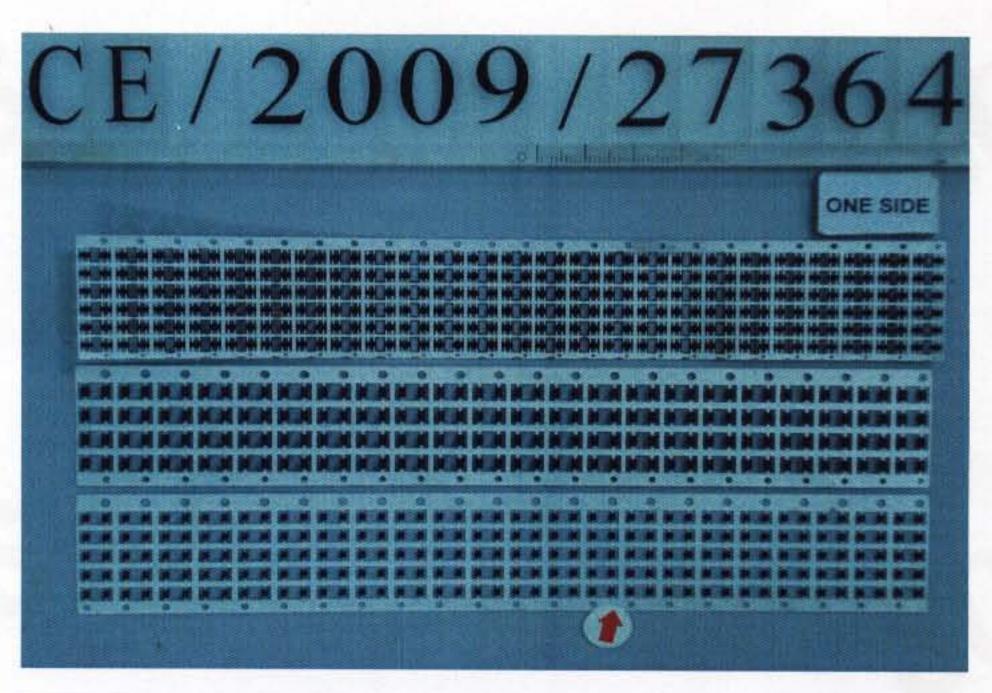
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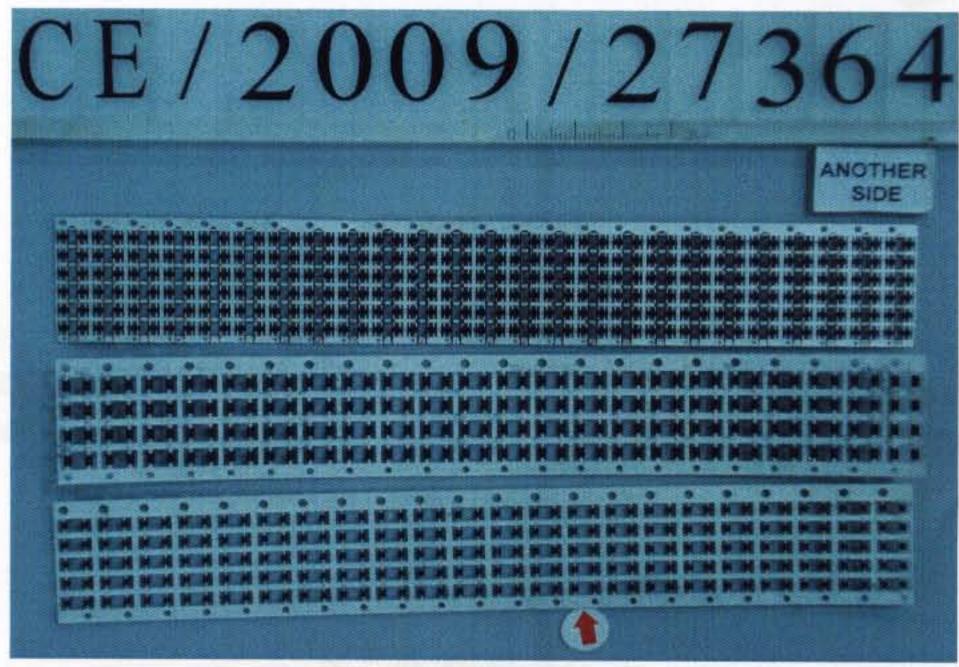


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\*\* End of Report \*\*

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